- Support Mixed-Mode Signal Operation (5-V Input and Output Voltages With $3.3-\mathrm{V} \mathrm{V}_{\mathrm{Cc}}$ )
- Support Unregulated Battery Operation Down to 2.7 V
- Typical $\mathrm{V}_{\text {OLP }}$ (Output Ground Bounce) $<0.8 \mathrm{~V}$ at $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$
- $\mathrm{I}_{\text {off }}$ and Power-Up 3-State Support Hot Insertion

SN54LVTH652 ... JT OR W PACKAGE
SN74LVTH652 . . . DB, DGV, DW, NS, OR PW PACKAGE (TOP VIEW)

| CLKAB | 1 | $\cup_{24}$ | 潅 |
| :---: | :---: | :---: | :---: |
| SAB | 2 | 23 | $]$ CLKBA |
| OEAB | 3 | 22 | SBA |
| A1 | 4 | 21 | OEBA |
| A2 | 5 | 20 | B1 |
| A3 | 6 | 19 | B2 |
| A4 | 7 | 18 | B3 |
| A5 | 8 | 17 | B4 |
| A6 | 9 | 16 | B5 |
| A7 | 10 | 15 | B6 |
| A8 | 11 | 14 | B7 |
| GND | 12 | 13 | B8 |

- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Latch-Up Performance Exceeds 500 mA Per JESD 17
- ESD Protection Exceeds JESD 22
- 2000-V Human-Body Model (A114-A)
- 200-V Machine Model (A115-A)

SN54LVTH652 . . . FK PACKAGE
(TOP VIEW)


NC - No internal connection

## description/ordering information

These bus transceivers and registers are designed specifically for low-voltage (3.3-V) $\mathrm{V}_{\mathrm{CC}}$ operation, but with the capability to provide a TTL interface to a $5-\mathrm{V}$ system environment.

ORDERING INFORMATION

| $\mathrm{T}_{\mathrm{A}}$ | PACKAGE $\dagger$ |  | ORDERABLE <br> PART NUMBER | TOP-SIDE MARKING |
| :---: | :---: | :---: | :---: | :---: |
| $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ | SOIC - DW | Tube | SN74LVTH652DW | LVTH652 |
|  |  | Tape and reel | SN74LVTH652DWR |  |
|  | SOP - NS | Tape and reel | SN74LVTH652NSR | LVTH652 |
|  | SSOP - DB | Tape and reel | SN74LVTH652DBR | LXH652 |
|  | TSSOP - PW | Tube | SN74LVTH652PW | LXH652 |
|  |  | Tape and reel | SN74LVTH652PWR |  |
|  | TVSOP - DGV | Tape and reel | SN74LVTH652DGVR | LXH652 |
| $-55^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ | CDIP - JT | Tube | SNJ54LVTH652JT | SNJ54LVTH652JT |
|  | CFP - W | Tube | SNJ54LVTH652W | SNJ54LVTH652W |
|  | LCCC - FK | Tube | SNJ54LVTH652FK | SNJ54LVTH652FK |

† Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

## description/ordering information (continued)

The 'LVTH652 devices consist of bus-transceiver circuits, D-type flip-flops, and control circuitry arranged for multiplexed transmission of data directly from the data bus or from the internal storage registers.
Output-enable (OEAB and $\overline{\mathrm{OEBA}}$ ) inputs are provided to control the transceiver functions. Select-control (SAB and SBA) inputs are provided to select whether real-time or stored data is transferred. The circuitry used for select control eliminates the typical decoding glitch that occurs in a multiplexer during the transition between real-time and stored data. A low input selects real-time data and a high input selects stored data. Figure 1 illustrates the four fundamental bus-management functions that can be performed with the 'LVTH652 devices.

Data on the A or B data bus, or both, can be stored in the internal D-type flip-flops by low-to-high transitions at the appropriate clock (CLKAB or CLKBA) inputs, regardless of the select- or enable-control pins. When SAB and SBA are in the real-time transfer mode, it is possible to store data without using the internal D-type flip-flops by simultaneously enabling OEAB and OEBA. In this configuration, each output reinforces its input; therefore, when all other data sources to the two sets of bus lines are at high impedance, each set of bus lines remains at its last state.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.
When $\mathrm{V}_{\mathrm{CC}}$ is between 0 and 1.5 V , the device is in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 1.5 V , $\overline{\mathrm{OE}}$ should be tied to $\mathrm{V}_{\mathrm{CC}}$ through a pullup resistor and OE should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sinking/current-sourcing capability of the driver.

This device is fully specified for hot-insertion applications using $\mathrm{I}_{\text {off }}$ and power-up 3-state. The $\mathrm{I}_{\text {off }}$ circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down. The power-up 3 -state circuitry places the outputs in the high-impedance state during power up and power down, which prevents driver conflict.

FUNCTION TABLE

| INPUTS |  |  |  |  |  | DATA I/O $\dagger$ |  | OPERATION OR FUNCTION |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| OEAB | $\overline{\text { OEBA }}$ | CLKAB | CLKBA | SAB | SBA | A1-A8 | B1-B8 |  |
| L | H | H or L | H or L | X | X | Input | Input | Isolation |
| L | H | $\uparrow$ | $\uparrow$ | X | X | Input | Input | Store $A$ and $B$ data |
| X | H | $\uparrow$ | H or L | X | X | Input | Unspecified $\ddagger$ | Store A, hold B |
| H | H | $\uparrow$ | $\uparrow$ | X $\ddagger$ | X | Input | Output | Store A in both registers |
| L | X | H or L | $\uparrow$ | X | X | Unspecified $\ddagger$ | Input | Hold A, store B |
| L | L | $\uparrow$ | $\uparrow$ | X | X $\ddagger$ | Output | Input | Store B in both registers |
| L | L | X | X | X | L | Output | Input | Real-time B data to $A$ bus |
| L | L | X | H or L | X | H | Output | Input | Stored $B$ data to $A$ bus |
| H | H | X | X | L | X | Input | Output | Real-time A data to B bus |
| H | H | H or L | X | H | X | Input | Output | Stored A data to B bus |
| H | L | H or L | H or L | H | H | Output | Output | Stored $A$ data to $B$ bus and stored $B$ data to $A$ bus |

[^0]

Pin numbers shown are for the DB, DGV, DW, JT, NS, PW, and W packages.
Figure 1. Bus-Management Functions
logic diagram (positive logic)


Pin numbers shown are for the DB, DGV, DW, JT, NS, PW, and W packages.

# absolute maximum ratings over operating free-air temperature range (unless otherwise noted) $\dagger$ 

| Supply voltage range, $\mathrm{V}_{\text {CC }}$ | -0.5 V to 4.6 V |
| :---: | :---: |
| Input voltage range, $\mathrm{V}_{1}$ (see Note 1) | -0.5 V to 7 V |
| Voltage range applied to any output in the high-impedance or power-off state, $\mathrm{V}_{\mathrm{O}}$ (see Note 1) | -0.5 V to 7 V |
| Voltage range applied to any output in the high state, $\mathrm{V}_{\mathrm{O}}$ (see Note 1) | -0.5 V to $\mathrm{V}_{\mathrm{Cc}}+0.5 \mathrm{~V}$ |
| Current into any output in the low state, $\mathrm{I}_{\mathrm{O}}$ : SN54LVTH652 | 96 mA |
| SN74LVTH652) | 128 mA |
| Current into any output in the high state, $\mathrm{I}_{\mathrm{O}}$ (see Note 2): SN54LVTH652 | 8 mA |
| SN74LVTH652 | 64 mA |
| Input clamp current, $\mathrm{I}_{\mathrm{K}}\left(\mathrm{V}_{1}<0\right)$ | -50 mA |
| Output clamp current, $\mathrm{l}_{\mathrm{OK}}\left(\mathrm{V}_{\mathrm{O}}<0\right)$ | -50 mA |
| Package thermal impedance, $\theta_{\mathrm{JA}}$ (see Note 3): DB package | $63^{\circ} \mathrm{C} / \mathrm{W}$ |
| DGV package | $86^{\circ} \mathrm{C} / \mathrm{W}$ |
| DW package | $46^{\circ} \mathrm{C} / \mathrm{W}$ |
| NS package | $65^{\circ} \mathrm{C} / \mathrm{W}$ |
| PW package | $88^{\circ} \mathrm{C} / \mathrm{W}$ |
| Storage temperature range, $\mathrm{T}_{\text {stg }}$ | $-65^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$ |

$\dagger$ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
2. This current flows only when the output is in the high state and $\mathrm{V}_{\mathrm{O}}>\mathrm{V}_{\mathrm{C}}$.
3. The package thermal impedance is calculated in accordance with JESD 51-7.
recommended operating conditions (see Note 4)


NOTE 4: All unused control inputs of the device must be held at $\mathrm{V}_{\mathrm{CC}}$ or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER |  | TEST CONDITIONS |  | SN54LVTH652 |  | SN74LVTH652 |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | MIN | TYP† MAX | MIN | TYP† | MAX |  |
| $\mathrm{V}_{\text {IK }}$ |  |  |  | $\mathrm{V}_{\mathrm{CC}}=2.7 \mathrm{~V}$, | $1 \mathrm{l}=-18 \mathrm{~mA}$ |  | -1.2 |  |  | -1.2 | V |
| $\mathrm{V}_{\mathrm{OH}}$ |  | $\mathrm{V}_{\mathrm{CC}}=2.7 \mathrm{~V}$ to 3.6 V, | $\mathrm{IOH}=-100 \mu \mathrm{~A}$ | $\mathrm{V}_{\mathrm{CC}}-0.2$ |  | $\mathrm{V}_{\mathrm{CC}}-0.2$ |  |  | V |
|  |  | $\mathrm{V}_{\mathrm{CC}}=2.7 \mathrm{~V}$, | $\mathrm{OH}=-8 \mathrm{~mA}$ | 2.4 |  | 2.4 |  |  |  |
|  |  | $\mathrm{V}_{\mathrm{CC}}=3 \mathrm{~V}$ | $\mathrm{I} \mathrm{OH}=-24 \mathrm{~mA}$ | 2 |  | 2 |  |  |  |
|  |  | $\mathrm{I} \mathrm{OH}=-32 \mathrm{~mA}$ |  |  |  |  |  |  |
| $\mathrm{V}_{\mathrm{OL}}$ |  |  | $\mathrm{V}_{\mathrm{CC}}=2.7 \mathrm{~V}$ | $\mathrm{IOL}=100 \mu \mathrm{~A}$ |  | 0.2 |  |  | 0.2 | V |
|  |  | $\mathrm{IOL}=24 \mathrm{~mA}$ |  |  | 0.5 |  |  | 0.5 |  |  |
|  |  | $\mathrm{V}_{\mathrm{CC}}=3 \mathrm{~V}$ | $\mathrm{IOL}=16 \mathrm{~mA}$ |  | 0.4 |  |  | 0.4 |  |  |
|  |  | $\mathrm{IOL}=32 \mathrm{~mA}$ |  | 0.5 |  |  | 0.5 |  |  |
|  |  | $\mathrm{IOL}=48 \mathrm{~mA}$ |  | 0.55 |  |  |  |  |  |
|  |  | $\mathrm{IOL}=64 \mathrm{~mA}$ |  | A |  |  | 0.55 |  |  |
| 1 | Control inputs |  | $\mathrm{V}_{\mathrm{CC}}=3.6 \mathrm{~V}, \quad \mathrm{~V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{CC}}$ or GND |  |  | $\pm 1$ |  |  | $\pm 1$ | $\mu \mathrm{A}$ |
|  |  |  | $\mathrm{V}_{\mathrm{CC}}=0$ or $3.6 \mathrm{~V}, \quad \mathrm{~V}_{\mathrm{I}}=5.5$ |  |  | ¢ 10 |  |  | 10 |  |
|  | A or B ports $\ddagger$ |  | $\mathrm{V}_{\mathrm{CC}}=3.6 \mathrm{~V}$ | $\mathrm{V}_{1}=5.5 \mathrm{~V}$ |  | 人 20 |  |  | 20 |  |
|  |  | $\mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{CC}}$ |  |  | $\bigcirc$ |  |  | 1 |  |  |
|  |  | $V_{1}=0$ |  |  | -5 |  |  | -5 |  |  |
| $\mathrm{l}_{\text {off }}$ |  | $\mathrm{V}_{\mathrm{CC}}=0, \quad \mathrm{~V}_{\text {I }}$ or $\mathrm{V}_{\mathrm{O}}=0$ to 4.5 V |  | Q |  |  |  | $\pm 100$ | $\mu \mathrm{A}$ |  |
| ${ }^{1}$ (hold) | A or B ports | $\mathrm{V}_{\mathrm{CC}}=3 \mathrm{~V}$ | $\mathrm{V}_{\mathrm{I}}=0.8 \mathrm{~V}$ | 75 |  | 75 |  |  | $\mu \mathrm{A}$ |  |
|  |  |  | $\mathrm{V}_{\mathrm{I}}=2 \mathrm{~V}$ | -75 |  | -75 |  |  |  |  |
|  |  | $\mathrm{V}_{\mathrm{CC}}=3.6 \mathrm{~V}$ § | $\mathrm{V}_{\mathrm{I}}=0$ to 3.6 V |  |  |  |  | $\pm 500$ |  |  |
| IOZPU |  | $\begin{aligned} & \mathrm{VCC}=0 \text { to } 1.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{O}}=0.5 \text { to } 3 \mathrm{~V}, \\ & \mathrm{OE} / \overline{\mathrm{OE}}=\text { don't care } \end{aligned}$ |  | $\pm 100^{*}$ |  | $\pm 100$ |  |  | $\mu \mathrm{A}$ |  |
| IOZPD |  | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}}=1.5 \mathrm{~V} \text { to } 0, \mathrm{~V}_{\mathrm{O}}=0.5 \text { to } 3 \mathrm{~V}, \\ & \mathrm{OE} / \mathrm{OE}=\text { don't care } \end{aligned}$ |  | $\pm 100^{*}$ |  | $\pm 100$ |  |  | $\mu \mathrm{A}$ |  |
| ICC |  | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}}=3.6 \mathrm{~V}, \mathrm{IO}=0, \\ & \mathrm{~V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{CC}} \text { or } \mathrm{GND} \end{aligned}$ | Outputs high |  | 0.19 |  |  | 0.19 | mA |  |
|  |  |  | Outputs low |  | 5 |  |  | 5 |  |  |
|  |  |  | Outputs disabled |  | 0.19 |  |  | 0.19 |  |  |
| ${ }^{\text {I CCC }}$ |  | $\mathrm{V}_{\mathrm{CC}}=3 \mathrm{~V}$ to 3.6 V , One input at $\mathrm{V}_{\mathrm{CC}}-0.6 \mathrm{~V}$, Other inputs at $\mathrm{V}_{\mathrm{CC}}$ or GND |  | 0.2 |  | 0.2 |  |  | mA |  |
| $\mathrm{C}_{\mathrm{i}}$ |  | $\mathrm{V}_{\mathrm{I}}=3 \mathrm{~V}$ or 0 |  | 4 |  | 4 |  |  | pF |  |
| $\mathrm{C}_{\mathrm{i}}$ |  | $\mathrm{V}_{\mathrm{O}}=3 \mathrm{~V}$ or 0 |  | 9 |  | 9 |  |  | pF |  |

* On products compliant to MIL-PRF-38535, this parameter is not production tested.
$\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
$\ddagger$ Unused terminals at $\mathrm{V}_{\mathrm{CC}}$ or GND
§ This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to another.
I This is the increase in supply current for each input that is at the specified TTL voltage level, rather than $V_{C C}$ or GND.
timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 2)

switching characteristics over recommended operating free-air temperature range, $\mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}$ (unless otherwise noted) (see Figure 2)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | SN54LVTH652 |  |  |  | SN74LVTH652 |  |  |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | $\begin{gathered} \hline \mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V} \\ \pm 0.3 \mathrm{~V} \end{gathered}$ |  | $\mathrm{V}_{\mathrm{CC}}=2.7 \mathrm{~V}$ |  | $\begin{gathered} \hline \mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V} \\ \pm 0.3 \mathrm{~V} \end{gathered}$ |  |  | $\mathrm{V}_{\mathrm{CC}}=2.7 \mathrm{~V}$ |  |  |
|  |  |  | MIN | MAX | MIN | MAX | MIN | TYP† | MAX | MIN | MAX |  |
| ${ }_{\text {f max }}$ |  |  | 150 |  | 150 |  | 150 |  |  | 150 |  | MHz |
| tplH | CLKBA or CLKAB | A or B | 1.7 | 5 |  | 5.9 | 1.8 | 3.1 | 4.7 |  | 5.6 |  |
| tPHL |  |  | 1.7 | 5 |  | 5.9 | 1.8 | 3.1 | 4.7 |  | 5.6 | ns |
| tPLH | $A$ or B | B or A | 1.2 | 3.7 |  | 4.3 | 1.3 | 2.3 | 3.5 |  | 4.1 |  |
| tPHL |  |  | 1.2 | 3.7 | 3 | 4.3 | 1.3 | 2.4 | 3.5 |  | 4.1 | ns |
| tPLH | SBA or SAB $\ddagger$ | A or B | 1.4 | 5.2 | 4 | 6.3 | 1.5 | 3.1 | 4.9 |  | 6 |  |
| tPHL |  |  | 1.4 | 5.2 |  | 6.3 | 1.5 | 3.4 | 4.9 |  | 6 | ns |
| tPZH | $\overline{\text { OEBA }}$ | A | 1 | 5.4 |  | 6.7 | 1.1 | 2.9 | 5.2 |  | 6.5 |  |
| tPZL |  |  | 1 | 5,4 |  | 6.7 | 1.1 | 3.1 | 5.2 |  | 6.5 | ns |
| tPHZ | $\overline{\text { OEBA }}$ | A | 2.2 | -5.9 |  | 6.5 | 2.3 | 3.5 | 5.5 |  | 6.1 |  |
| tPLZ |  |  | 2.2 | 5.9 |  | 6.3 | 2.3 | 3.7 | 5.5 |  | 5.9 | ns |
| tPZH | OEAB | B | 1.2 | 4.9 |  | 5.9 | 1.3 | 3 | 4.7 |  | 5.7 |  |
| tPZL |  |  | 1.2 | 4.9 |  | 5.9 | 1.3 | 3.3 | 4.7 |  | 5.7 | ns |
| tPHZ | OEAB | B | 1.4 | 5.8 |  | 7 | 1.5 | 3.6 | 5.6 |  | 6.7 | ns |
| tpLZ |  |  | 1.4 | 5.9 |  | 6.6 | 1.5 | 3.7 | 5.6 |  | 6.3 |  |

$\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
$\ddagger$ These parameters are measured with the internal output state of the storage register opposite that of the bus input.

## PARAMETER MEASUREMENT INFORMATION




| TEST | S1 |
| :---: | :---: |
| tPLH/tPHL | Open |
| tPLZ/tPZL | 6 V |
| tPHZ/tPZH | GND |



VOLTAGE WAVEFORMS PROPAGATION DELAY TIMES INVERTING AND NONINVERTING OUTPUTS


VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES
LOW- AND HIGH-LEVEL ENABLING

NOTES: A. $\mathrm{C}_{\mathrm{L}}$ includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. All input pulses are supplied by generators having the following characteristics: $\mathrm{PRR} \leq 10 \mathrm{MHz}, \mathrm{Z}_{\mathrm{O}}=50 \Omega, \mathrm{t}_{\mathrm{r}} \leq 2.5 \mathrm{~ns}, \mathrm{t}_{\mathrm{f}} \leq 2.5 \mathrm{~ns}$.
D. The outputs are measured one at a time with one transition per measurement.
E. All parameters and waveforms are not applicable to all devices.

Figure 2. Load Circuit and Voltage Waveforms

## PACKAGING INFORMATION

| Orderable Device | Status <br> (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan <br> (2) | Lead finish/ Ball material (6) | MSL Peak Temp <br> (3) | Op Temp ( ${ }^{\circ} \mathrm{C}$ ) | Device Marking <br> (4/5) | Samples |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SN74LVTH652DW | ACTIVE | SOIC | DW | 24 | 25 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | LVTH652 | Samples |
| SN74LVTH652PW | ACTIVE | TSSOP | PW | 24 | 60 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | LXH652 | Samples |
| SN74LVTH652PWR | ACTIVE | TSSOP | PW | 24 | 2000 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | LXH652 | Samples |

${ }^{(1)}$ The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but Tl does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.
${ }^{(2)}$ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed $0.1 \%$ by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the $<=1000 \mathrm{ppm}$ threshold requirement.
${ }^{(3)}$ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
${ }^{(4)}$ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
${ }^{(5)}$ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
${ }^{(6)}$ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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## TAPE AND REEL INFORMATION


*All dimensions are nominal

| Device | Package <br> Type | Package <br> Drawing | Pins | SPQ | Reel <br> Diameter <br> $(\mathbf{m m})$ | Reel <br> Width <br> W1 $(\mathbf{m m})$ | A0 <br> $(\mathbf{m m})$ | B0 <br> $(\mathbf{m m})$ | K0 <br> $(\mathbf{m m})$ | P1 <br> $(\mathbf{m m})$ | W <br> $(\mathbf{m m})$ | Pin1 <br> Quadrant |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SN74LVTH652PWR | TSSOP | PW | 24 | 2000 | 330.0 | 16.4 | 6.95 | 8.3 | 1.6 | 8.0 | 16.0 | Q1 |


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SN74LVTH652PWR | TSSOP | PW | 24 | 2000 | 853.0 | 449.0 | 35.0 |



NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.


NOTES: (continued)
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site


SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL SCALE: 10X

NOTES: (continued)
8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

DW (R-PDSO-G24) PLASTIC SMALL OUTLINE


NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion not to exceed $0.006(0,15)$.
D. Falls within JEDEC MS-013 variation AD.

DW (R-PDSO-G24)

NOTES:
A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Refer to IPC7351 for alternate board design.
D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525
E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

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[^0]:    $\dagger$ The data-output functions can be enabled or disabled by a variety of level combinations at OEAB or $\overline{O E B A}$. Data-input functions always are enabled; i.e., data at the bus terminals is stored on every low-to-high transition of the clock inputs.
    $\ddagger$ Select control = L; clocks can occur simultaneously.
    Select control = H; clocks must be staggered to load both registers.

